

<b>Notice of References Cited</b>			Application/Control No.	Applicant(s)/Patent Under Reexamination IWANE ET AL.	
			Examiner Matthew A. Anderson	Art Unit 1765	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
X	A	US-3756194	09-1973	Lien	118/52
X	B	US-4026240	05-1977	DeFevere	118/415
X	C	US-5544616	08-1996	Ciszek et al.	117/60
X	D	US-5846319	12-1998	Barton	117/60
X	E	US-5871580	02-1999	Asahi et al.	117/83
X	F	US-6231667 B1	05-2001	Iwane et al.	117/55
X	G	US-6391108 B2	05-2002	Nishida et al.	117/77
X	H	US-2002/0005158 A1	01-2002	Nishida et al.	117/2
X	I	US-2002/0112660 A1	08-2002	Nishida et al.	117/54
X	J	US-			
X	K	US-			
X	L	US-			
X	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
X	N					
X	O					
X	P					
X	Q					
X	R					
X	S					
X	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages
X	U	
X	V	
X	W	
X	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

6/29/04

Matthew A. Anderson